

Notice of References Cited	Application/Control No. 10/578,679		Applicant(s)/Patent Under Reexamination REILLY ET AL.	
	Examiner BIN SHEN		Art Unit 1657	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Butcher et al. "Vacuum Ultraviolet Radiation for Single-Photoionization Mass Spectrometry: A Review", Microchemical Journal, 1999, 62:354-362.
	V	Muhlberger et al. "Single Photon Ionization (SPI) via Incoherent VUV-Excimer Light: Robust and Compact Time-of-Flight Mass Spectrometer for On-line, Real-Time Process Gas Analysis". Anal. Chem. 2002, 74:3790-3801.
	W	Baldwin et al. "Matrix-Assisted Laser Desorption/Ionization coupled with Quadrupole/Orthogonal Accelation Time-of-Flight Mass Spectrometry for Protein Discovery, Identification, and structural anlysis", Anal. Chem. 2001, 73:1707-1720.
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.